



# FDMS9620S

## Dual N-Channel PowerTrench<sup>®</sup> MOSFET

Q1: 30V, 16A, 21.5mΩ Q2: 30V, 18A, 13mΩ

### Features

Q1: N-Channel

- Max  $r_{DS(on)}$  = 21.5mΩ at  $V_{GS} = 10V$ ,  $I_D = 7.5A$
- Max  $r_{DS(on)}$  = 29.5mΩ at  $V_{GS} = 4.5V$ ,  $I_D = 6.5A$

Q2: N-Channel

- Max  $r_{DS(on)}$  = 13mΩ at  $V_{GS} = 10V$ ,  $I_D = 10A$
- Max  $r_{DS(on)}$  = 17mΩ at  $V_{GS} = 4.5V$ ,  $I_D = 8.5A$
- Low Qg high side MOSFET
- Low  $r_{DS(on)}$  low side MOSFET
- Thermally efficient dual Power 56 package
- Pinout optimized for simple PCB design
- RoHS Compliant



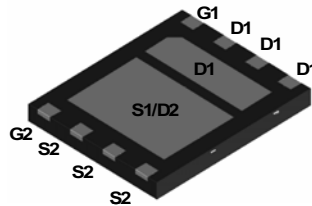
### General Description

This device includes two specialized MOSFETs in a unique dual Power 56 package. It is designed to provide an optimal Synchronous Buck power stage in terms of efficiency and PCB utilization. The low switching loss "High Side" MOSFET is complemented by a Low Conduction Loss "Low Side" SyncFET.

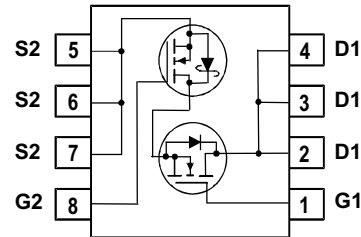
### Applications

Synchronous Buck Converter for:

- Notebook System Power
- General Purpose Point of Load



Power 56



### MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Q1	Q2	Units
$V_{DS}$	Drain to Source Voltage	30	30	V
$V_{GS}$	Gate to Source Voltage	$\pm 20$	$\pm 20$	V
$I_D$	Drain Current -Continuous $T_C = 25^\circ C$	16	18	A
	-Continuous $T_A = 25^\circ C$ (Note 1a)	7.5	10	
	-Pulsed	60	60	
$P_D$	Power Dissipation for Single Operation $T_A = 25^\circ C$ (Note 1a)	2.5		W
	$T_A = 25^\circ C$ (Note 1b)	1		
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150		$^\circ C$

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	8.2	3.1	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50		
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	120		

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS9620S	FDMS9620S	Power 56	13"	12mm	3000 units

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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**Off Characteristics**

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$ $I_D = 1\text{mA}$ , $V_{GS} = 0\text{V}$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , referenced to $25^\circ\text{C}$ $I_D = 1\text{mA}$ , referenced to $25^\circ\text{C}$	Q1 Q2		23 23		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 24\text{V}$ , $V_{GS} = 0\text{V}$	Q1 Q2			1 500	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}$ , $V_{DS} = 0\text{V}$	Q1 Q2			$\pm 100$ $\pm 100$	nA

**On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 250\mu\text{A}$ $V_{GS} = V_{DS}$ , $I_D = 1\text{mA}$	Q1 Q2	1 1	1.6 1.6	3 3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$ , referenced to $25^\circ\text{C}$ $I_D = 1\text{mA}$ , referenced to $25^\circ\text{C}$	Q1 Q2		-4 -4		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Drain to Source On Resistance	$V_{GS} = 10\text{V}$ , $I_D = 7.5\text{A}$ $V_{GS} = 4.5\text{V}$ , $I_D = 6.5\text{A}$ $V_{GS} = 10\text{V}$ , $I_D = 7.5\text{A}$ , $T_J = 125^\circ\text{C}$	Q1		18 23 25	21.5 29.5 32	m $\Omega$
		$V_{GS} = 10\text{V}$ , $I_D = 10\text{A}$ $V_{GS} = 4.5\text{V}$ , $I_D = 8.5\text{A}$ $V_{GS} = 10\text{V}$ , $I_D = 10\text{A}$ , $T_J = 125^\circ\text{C}$	Q2		9 13 14	13 17 22	
$g_{FS}$	Forward Transconductance	$V_{DD} = 10\text{V}$ , $I_D = 7.5\text{A}$ $V_{DD} = 10\text{V}$ , $I_D = 10\text{A}$	Q1		25		S
			Q2		27		

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = 15\text{V}$ , $V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$	Q1 Q2		500 700	665 935	pF
$C_{oss}$	Output Capacitance		Q1 Q2		100 500	135 665	
$C_{rss}$	Reverse Transfer Capacitance		Q1 Q2		65 100	100 150	pF
$R_g$	Gate Resistance		$f = 1\text{MHz}$	Q1 Q2		0.9 1.8	

**Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 15\text{V}$ , $I_D = 1\text{A}$ , $V_{GS} = 10\text{V}$ , $R_{GEN} = 6\Omega$	Q1 Q2		11 15	20 27	ns	
$t_r$	Rise Time		Q1 Q2		7 13	14 24		ns
$t_{d(off)}$	Turn-Off Delay Time		Q1 Q2		23 27	37 44	ns	
$t_f$	Fall Time		Q1 Q2		2.3 7	10 14		ns
$Q_g$	Total Gate Charge		Q1 $V_{DD} = 15\text{V}$ , $V_{GS} = 10\text{V}$ , $I_D = 7.5\text{A}$	Q1		10	14	
				Q2		18	25	
$Q_{gs}$	Gate to Source Gate Charge		Q2 $V_{DD} = 15\text{V}$ , $V_{GS} = 10\text{V}$ , $I_D = 10\text{A}$	Q1		1.7		nC
				Q2		2.8		
$Q_{gd}$	Gate to Drain "Miller" Charge		Q1		2.0		nC	
			Q2		3.6			

### Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
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#### Drain-Source Diode Characteristics

$I_S$	Maximum Continuous Drain-Source Diode Forward Current		Q1 Q2			2.1 3.5	A
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_S = 2.1A$ (Note 2) $V_{GS} = 0V, I_S = 3.5A$ (Note 2)	Q1 Q2		0.7 0.5	1.2 1.0	V
$t_{rr}$	Reverse Recovery Time	Q1 $I_F = 7.5A, di/dt = 100A/\mu s$	Q1 Q2		13 14		ns
$Q_{rr}$	Reverse Recovery Charge	Q2 $I_F = 10A, di/dt = 300A/\mu s$	Q1 Q2		4 9		nC

**Notes:**

1:  $R_{\theta JA}$  is determined with the device mounted on a  $1\text{in}^2$  pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



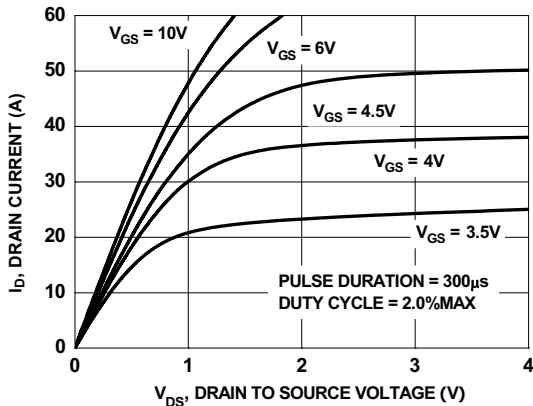
a.  $50^\circ\text{C/W}$  when mounted on a  $1\text{in}^2$  pad of 2 oz copper



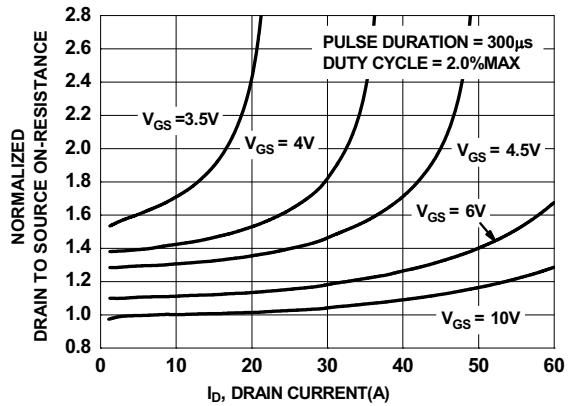
b.  $120^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper

2: Pulse Test: Pulse Width <  $300\mu s$ , Duty cycle < 2.0%.

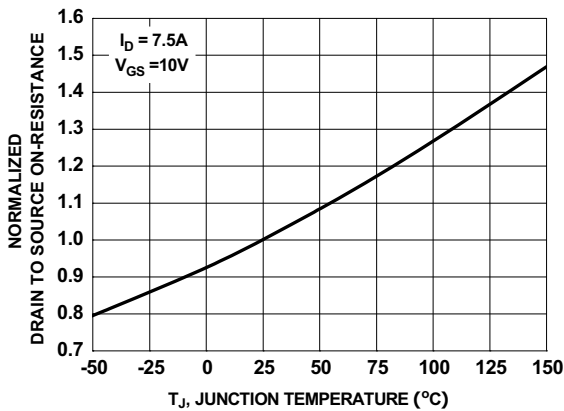
**Typical Characteristics (Q1 N-Channel)**  $T_J = 25^\circ\text{C}$  unless otherwise noted



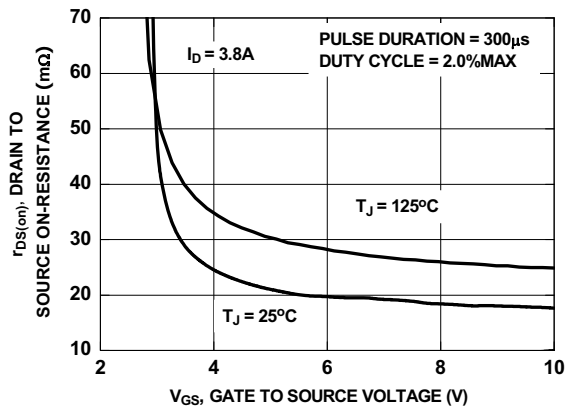
**Figure 1. On Region Characteristics**



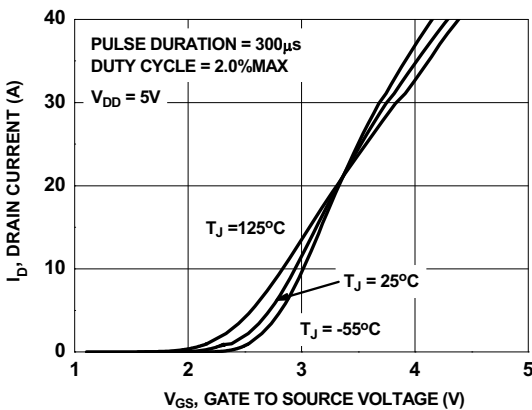
**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**



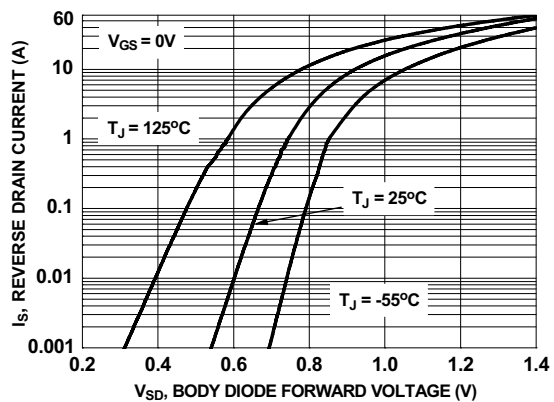
**Figure 3. Normalized On Resistance vs Junction Temperature**



**Figure 4. On-Resistance vs Gate to Source Voltage**

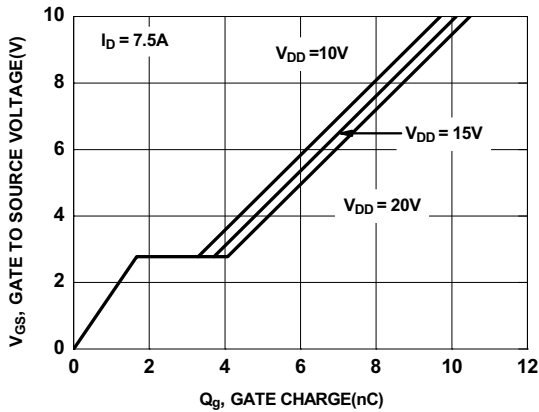


**Figure 5. Transfer Characteristics**

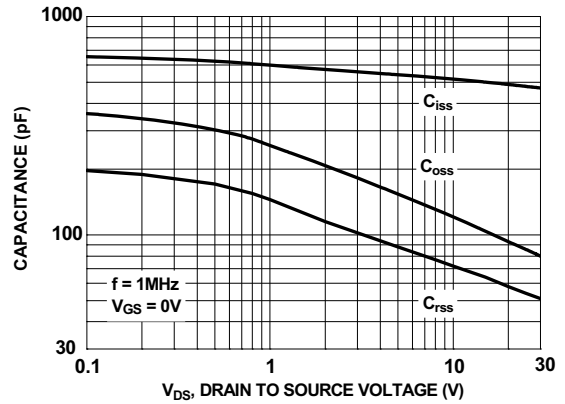


**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

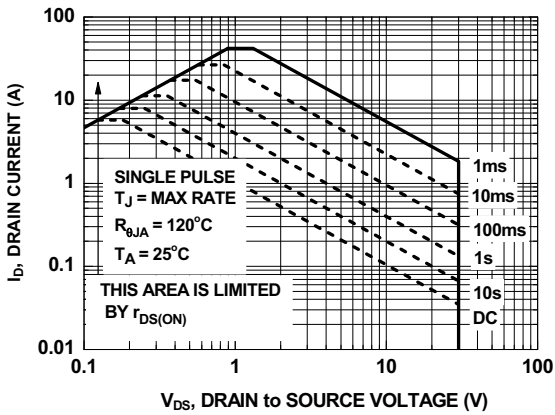
**Typical Characteristics (Q1 N-Channel)**  $T_J = 25^\circ\text{C}$  unless otherwise noted



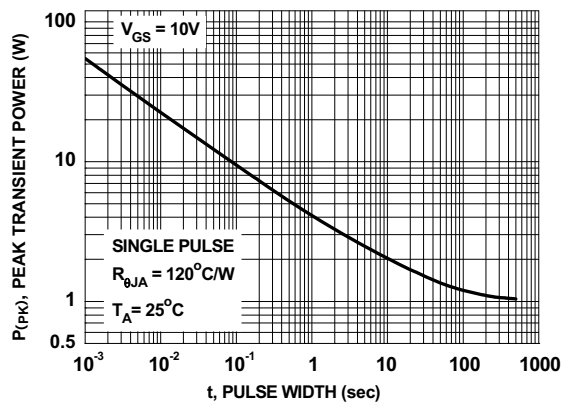
**Figure 7. Gate Charge Characteristics**



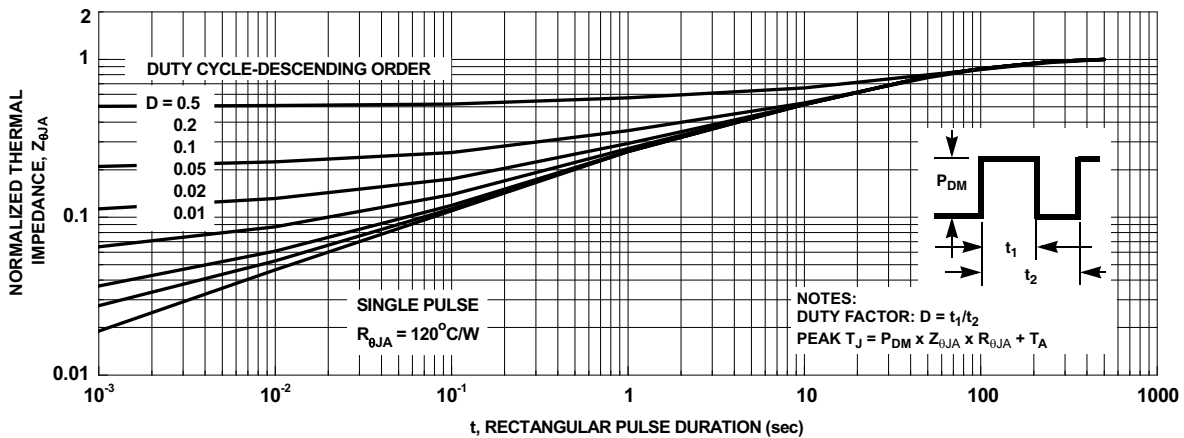
**Figure 8. Capacitance vs Drain to Source Voltage**



**Figure 9. Forward Bias Safe Operating Area**



**Figure 10. Single Pulse Maximum Power Dissipation**



**Figure 11. Transient Thermal Response Curve**

### Typical Characteristics (Q2 SyncFET)

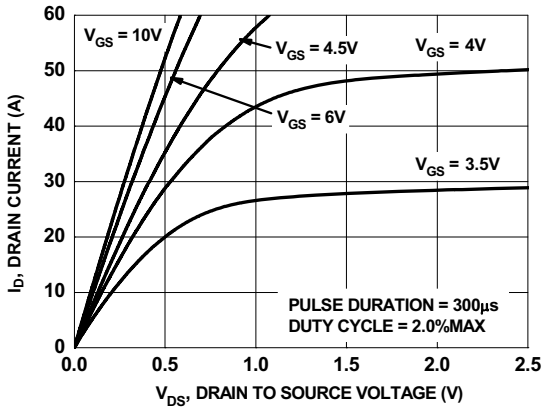


Figure 12. On-Region Characteristics

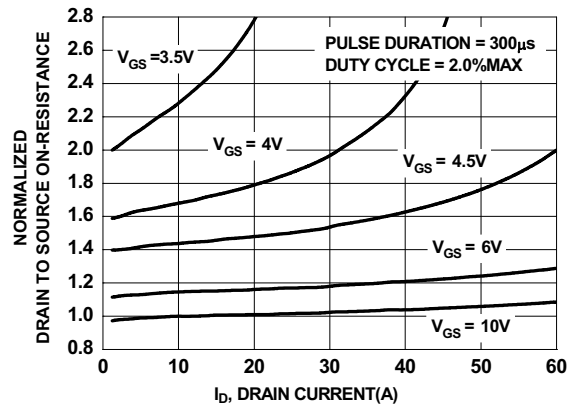


Figure 13. Normalized on-Resistance vs Drain Current and Gate Voltage

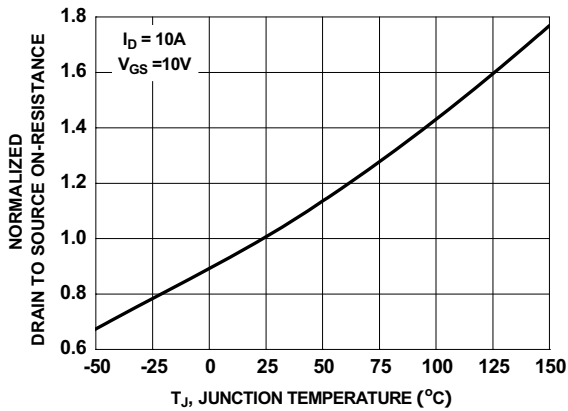


Figure 14. Normalized On-Resistance vs Junction Temperature

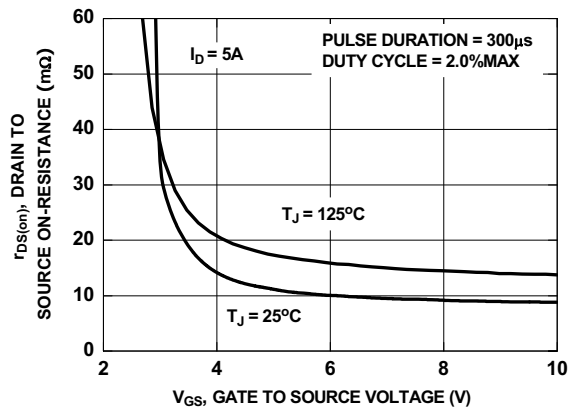


Figure 15. On-Resistance vs Gate to Source Voltage

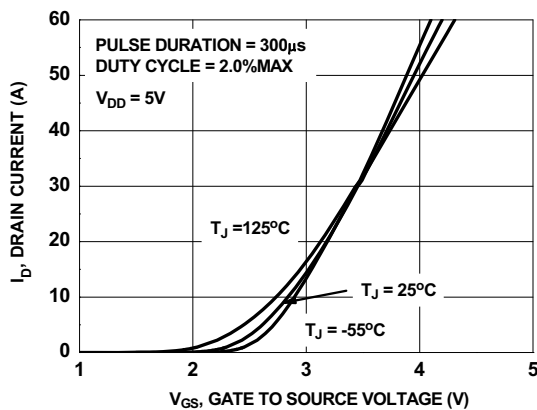


Figure 16. Transfer Characteristics

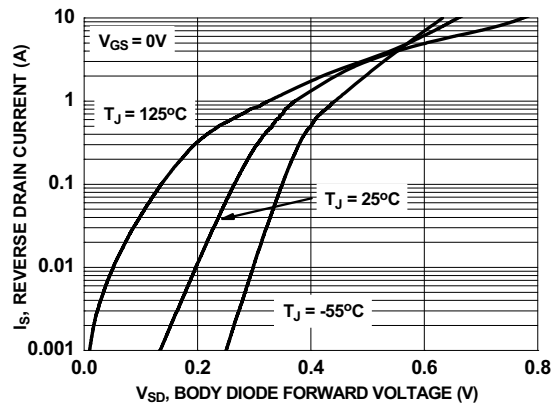


Figure 17. Source to Drain Diode Forward Voltage vs Source Current

### Typical Characteristics

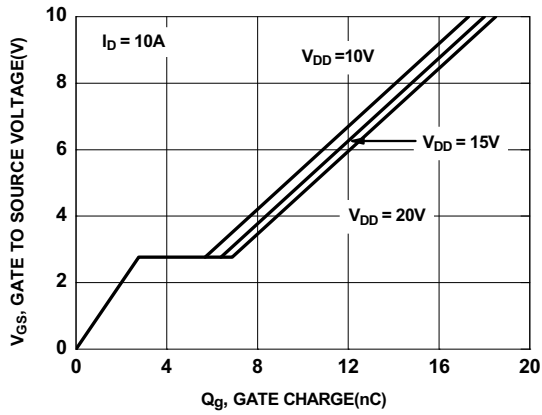


Figure 18. Gate Charge Characteristics

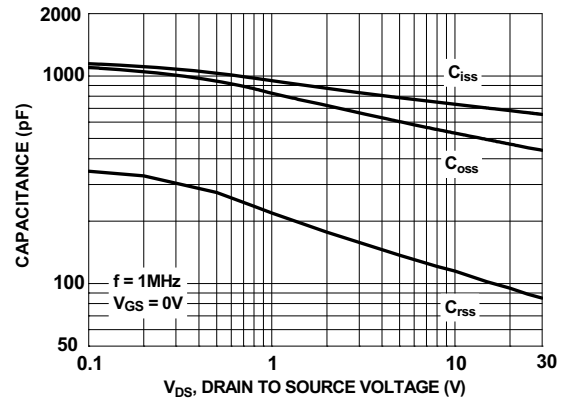
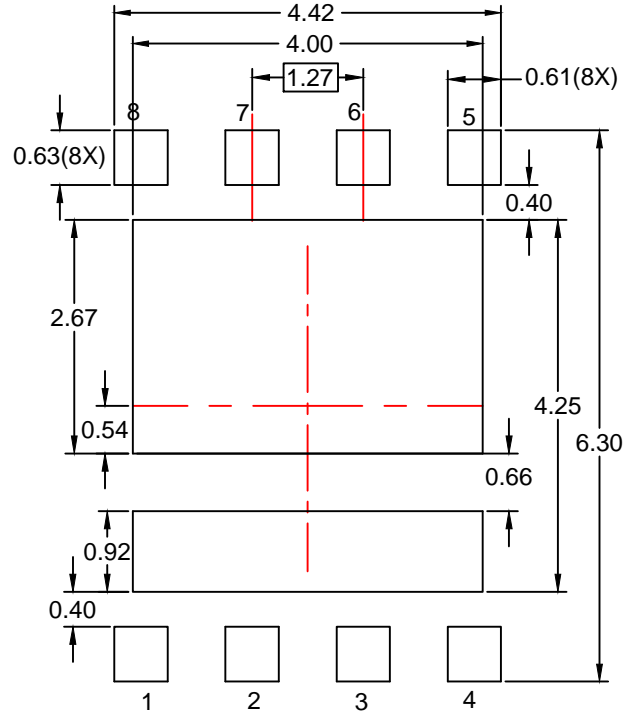
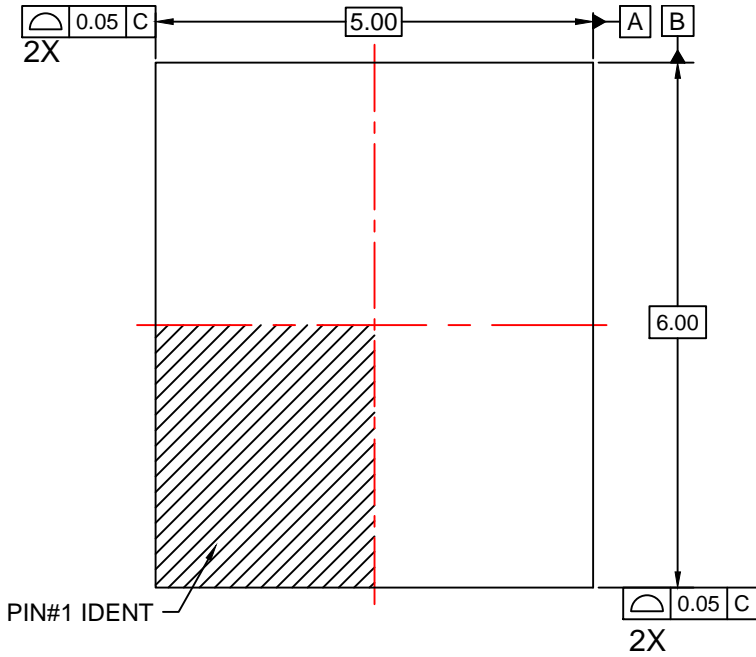
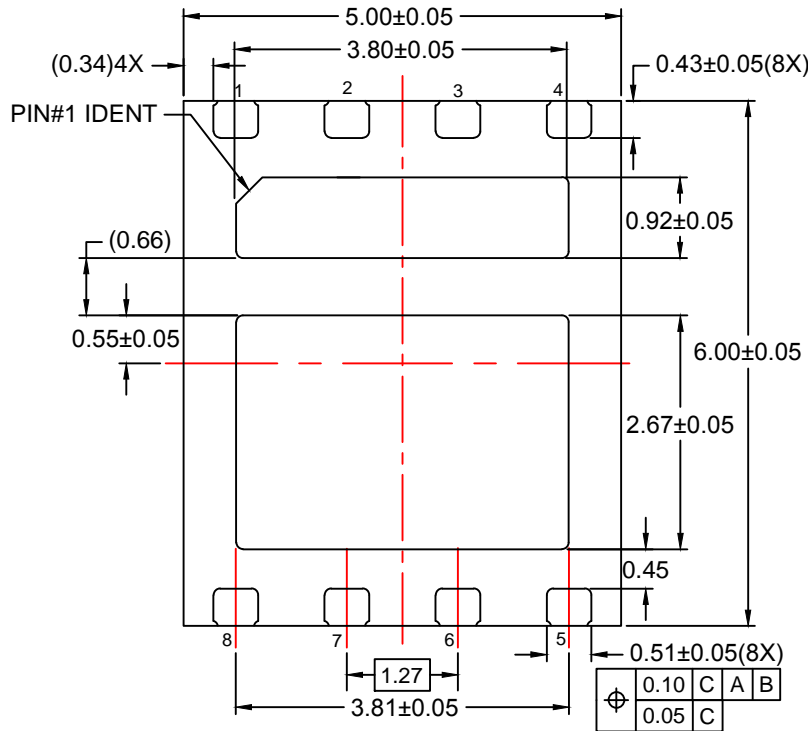
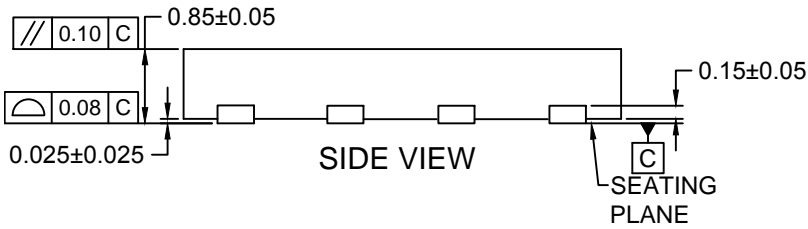


Figure 19. Capacitance vs Drain to Source Voltage



RECOMMENDED LAND PATTERN



BOTTOM VIEW

NOTES:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Krev2.












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